Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10551901	MIURA ET AL.
Examiner	Art Unit
Jeffrey T Palenik	1615

SEARCHED

Class	Subclass	Date	Examiner
424	489	4/7/2008	JTP
514	161, 171, 247, 252, 423	4/7/2008	JTP
424	No classified search performed.	11/13/2008	JTP
514	No classified search performed.	11/13/2008	JTP
241	No classified search performed.	11/13/2008	JTP
	No classified search performed.	5/30/2011	JTP

SEARCH NOTES

Search Notes	Date	Examiner
Inventor search	4/7/2008	JTP
EAST search (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	4/7/2008	JTP
Google search	4/7/2008	JTP
Inventor search updated in PALM (eDAN) and EAST	11/14/2008	JTP
EAST search updated (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB) see attached history for terms searched	11/14/2008	JTP
STIC searched submitted	11/14/2008	JTP
Called EKA (an AkzoNobel company) regarding continuity between Nyacol 9950 and Bindzil 9950	9/9/2009	JTP
Google NPL search for specific surface area for silica materials (see USPGPub 2003/0220204)	9/9/2009	JTP
EAST search updated (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB) see attached history for terms searched	5/30/2011	JTP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	(light anhydrous silicic or hydrated silicon dioxide or silicon dioxide or calcium silicate).clm. and (supercritical or subcritical) near2 carbon dioxide.clm. and pore diameter	9/12/2011	JTP

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